

## WIDE-INPUT SYNCHRONOUS, BUCK CONTROLLER

### FEATURES

- Operating Input Voltage 10 V to 40 V
- Programmable Fixed-Frequency Up to 100 kHz to 1 MHz Voltage Mode Controller
- Internal Gate Drive Outputs for High-Side and Synchronous N-Channel MOSFETs
- 16-Pin PowerPAD™ Package ( $\theta_{JC} = 2^{\circ}\text{C/W}$ )
- Thermal Shutdown
- Externally Synchronizable
- Programmable Short-Circuit Protection
- Programmable Closed-Loop Soft-Start

### APPLICATIONS

- DDR Tracking Regulators
- Power Modules
- Networking Equipment
- Industrial Servers

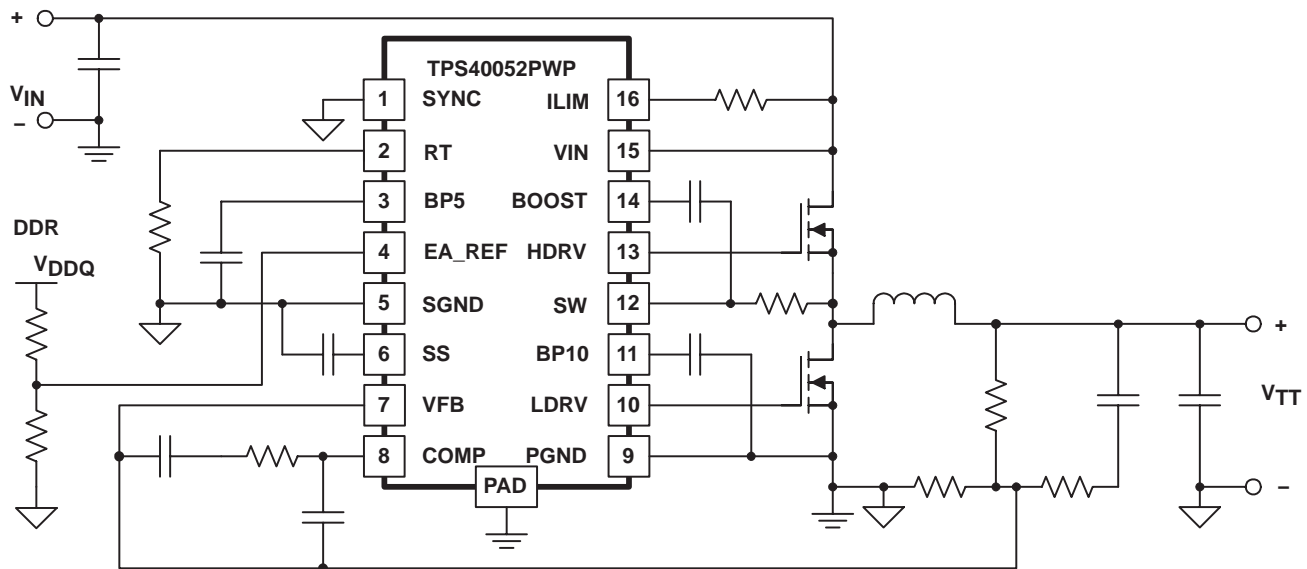
### DESCRIPTION

The TPS40052 is part of a family of high-voltage, wide input, synchronous, step-down converters. The TPS40052 offers design flexibility with a variety of user programmable functions, including soft-start, operating frequency, high-side current limit, and loop compensation.

The TPS40052 is also synchronizable to an external supply. It incorporates MOSFET gate drivers for external N-channel high-side and synchronous rectifier (SR) MOSFETs. Gate drive logic incorporates anti-cross conduction circuitry to prevent simultaneous high-side and synchronous rectifier conduction.

The externally programmable short circuit protection provides pulse-by-pulse current limit, as well as hiccup mode operation utilizing an internal fault counter for longer duration overloads.

### SIMPLIFIED APPLICATION DIAGRAM



UDG-03080



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

**ORDERING INFORMATION**

T <sub>A</sub>	PACKAGE	PART NUMBER
-40°C to 85°C	Plastic HTSSOP(PWP)(1)	TPS40052PWP

(1) The PWP package is also available taped and reeled. Add an R suffix to the device type (i.e., TPS40052PWPR). See the application section of the data sheet for PowerPAD drawing and layout information.

**ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range unless otherwise noted(2)

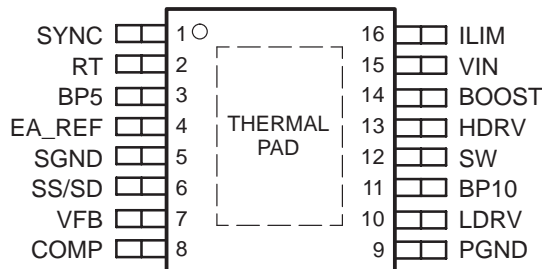
		TPS40052	UNIT
Input voltage range, V <sub>IN</sub>	VIN	45	V
	VFB, SS, SYNC, EA_REF	-0.3 to 6	
	SW	-0.3 to 45	
	SW, transient < 50 ns	-2.5	
Output voltage range, V <sub>O</sub>	COMP, RT, SS	-0.3 to 6	
Output current, I <sub>OUT</sub>	RT	200	μA
Operating junction temperature range, T <sub>J</sub>		-40 to 125	°C
Storage temperature, T <sub>stg</sub>		-55 to 150	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260	

(2) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

**RECOMMENDED OPERATING CONDITIONS**

	MIN	NOM	MAX	UNIT
Input voltage, V <sub>I</sub>	10		40	V
Operating free-air temperature, T <sub>A</sub>	-40		85	°C

PWP PACKAGE(3)(4)  
(TOP VIEW)



(3) For more information on the PWP package, refer to TI Technical Brief, Literature No. SLMA002.

(4) PowerPAD™ heat slug must be connected to SGND (pin 5) or electrically isolated from all other pins.

**ELECTRICAL CHARACTERISTICS**

$T_A = -40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ ,  $V_{IN} = 12\text{ V}_{\text{DC}}$ ,  $R_T = 90.9\text{ k}\Omega$ ,  $f_{\text{SW}} = 500\text{ kHz}$ ,  $V_{\text{EA\_REF}} = 1.25\text{ V}$ , all parameters at zero power dissipation (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
<b>INPUT SUPPLY</b>							
$V_{IN}$	Input voltage range, $V_{IN}$	10		40	V		
<b>OPERATING CURRENT</b>							
$I_{\text{DD}}$	Quiescent current	Output drivers not switching, $V_{\text{FB}} = 1.3\text{ V}$		1.5	3.0	mA	
<b>BP5</b>							
$V_{\text{BP5}}$	Output voltage	$I_{\text{LOAD}} = 1\text{ mA}$		4.5	5.0	5.5	V
<b>OSCILLATOR/RAMP GENERATOR</b>							
$f_{\text{OSC}}$	Accuracy	$9\text{ V} \leq V_{IN} \leq 40\text{ V}$		450	500	550	kHz
$V_{\text{RAMP}}$	PWM ramp voltage <sup>(1)</sup>	$V_{\text{PEAK}} - V_{\text{VAL}}$		2.0		V	
$V_{\text{IH}}$	High-level input voltage, SYNC			2	5		
$V_{\text{IL}}$	Low-level input voltage, SYNC			0.8		V	
$I_{\text{SYNC}}$	Input current, SYNC			5	10	$\mu\text{A}$	
	Pulse width, SYNC			50		ns	
$V_{\text{RT}}$	$R_T$ voltage			2.38	2.50	2.58	V
	Maximum duty cycle	$V_{\text{FB}} = 0\text{ V}$ , $f_{\text{SW}} \leq 500\text{ kHz}$		80%	94%		
	Minimum duty cycle	$V_{\text{FB}} \geq 1.3\text{ V}$		75%	0%		
<b>SOFT START</b>							
$I_{\text{SS}}$	Soft-start source current			1.75	2.35	3.05	$\mu\text{A}$
$V_{\text{SS}}$	Soft-start clamp voltage			3.7		V	
$t_{\text{DSCH}}$	Discharge time	$C_{\text{SS}} = 220\text{ pF}$		1.6	2.2	2.8	$\mu\text{s}$
$t_{\text{SS}}$	Soft-start time	$C_{\text{SS}} = 220\text{ pF}$ , $0\text{ V} \leq V_{\text{SS}} \leq 1.6\text{ V}$		100	155	195	
<b>BP10</b>							
$V_{\text{BP10}}$	Output voltage			9.0	9.6	10.3	V
<b>ERROR AMPLIFIER</b>							
$V_{\text{EA\_REF}}$	Error amplifier reference input voltage <sup>(2)</sup>	$9\text{ V} \leq V_{IN} \leq 40\text{ V}$		0.5	0.7	1.5	V
	Input offset voltage	$0.5\text{ V} \leq V_{\text{FB}} \leq 1.5\text{ V}$		-5	5		mV
$G_{\text{BW}}$	Gain bandwidth			3	5		MHz
$A_{\text{VOL}}$	Open loop gain			60	80		dB
$I_{\text{OH}}$	High-level output source current			2.0	4.0		mA
$I_{\text{OL}}$	Low-level output sink current			2.5	4.0		
$V_{\text{OH}}$	High-level output voltage	$I_{\text{SOURCE}} = 500\text{ }\mu\text{A}$		3.2	3.5		V
$V_{\text{OL}}$	Low-level output voltage	$I_{\text{SINK}} = 500\text{ }\mu\text{A}$		0.20	0.35		
$I_{\text{BIAS}}$	Input bias current	$V_{\text{FB}} = 0.7\text{ V}$		100	200		nA

(1) Ensured by design. Not production tested.

(2) Common mode range extends to ground, but not tested below 500 mV.

**ELECTRICAL CHARACTERISTICS**

T<sub>A</sub> = -40°C to 85°C, V<sub>IN</sub> = 12 V<sub>dc</sub>, R<sub>T</sub> = 90.9 kΩ, f<sub>SW</sub> = 500 kHz, V<sub>EA\_REF</sub> = 1.25 V all parameters at zero power dissipation (unless otherwise noted)

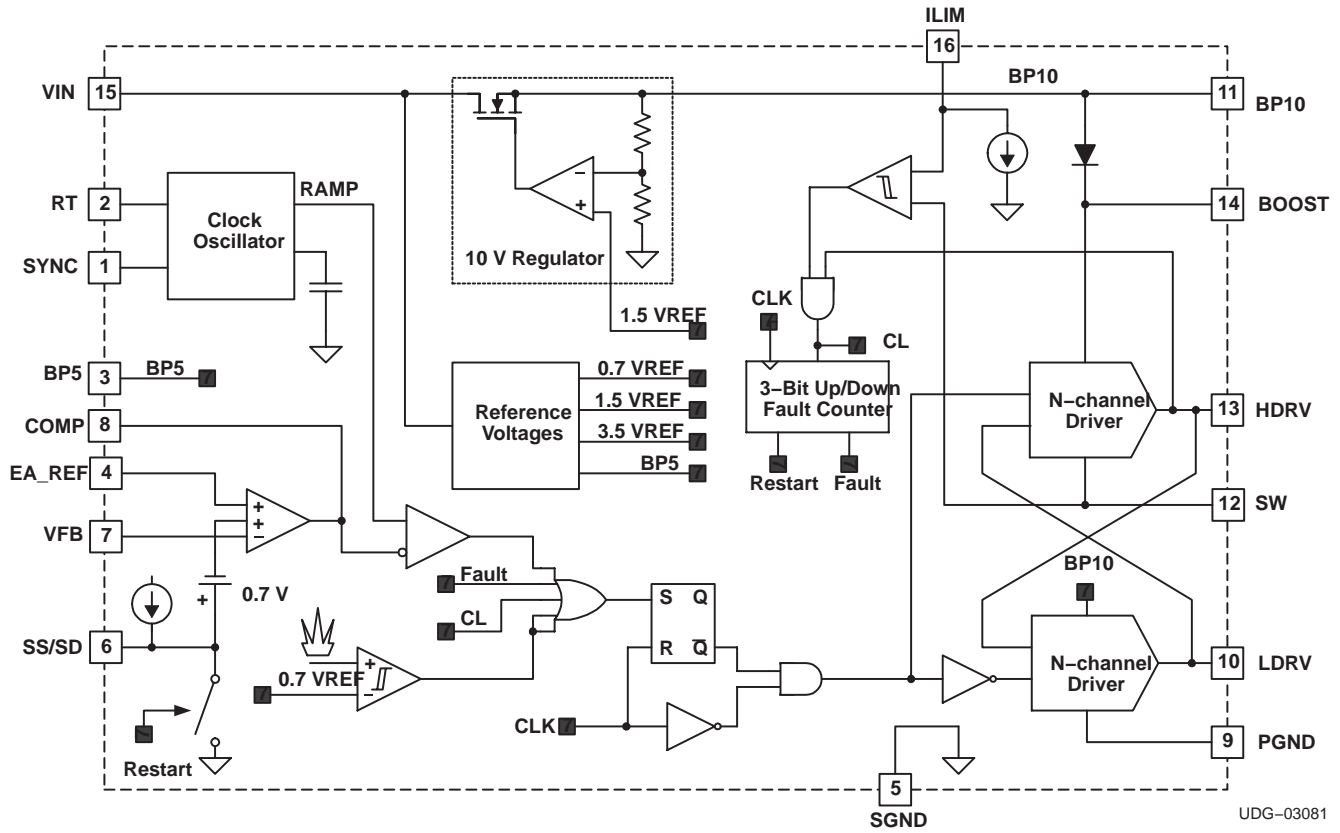
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>CURRENT LIMIT</b>						
I <sub>SINK</sub>	Current limit sink current		8.6	10.0	11.8	μA
	Propagation delay to output	V <sub>ILIM</sub> = 11.7 V, V <sub>SW</sub> = (V <sub>ILIM</sub> - 0.5 V)		400		ns
		V <sub>ILIM</sub> = 11.7 V, V <sub>SW</sub> = (V <sub>ILIM</sub> - 2 V)		300		
t <sub>ON</sub>	Switch leading-edge blanking pulse time <sup>(1)</sup>		100			
t <sub>OFF</sub>	Off time during a fault			7		cycles
V <sub>OS</sub>	Offset voltage SW vs. ILIM	V <sub>ILIM</sub> = 11.6 V, T <sub>A</sub> = 25°C	-180	-110	-20	mV
		V <sub>ILIM</sub> = 11.6 V, 0°C ≤ T <sub>A</sub> ≤ 85°C	-200	-110	0	
		V <sub>ILIM</sub> = 11.6 V, -40°C ≤ T <sub>A</sub> ≤ 85°C	-200	-110	30	
<b>OUTPUT DRIVER</b>						
t <sub>LRISE</sub>	Low-side driver rise time	C <sub>LOAD</sub> = 2200 pF		48	96	ns
t <sub>LFALL</sub>	Low-side driver fall time			24	48	
t <sub>HRISE</sub>	High-side driver rise time	C <sub>LOAD</sub> = 2200 pF, (HDRV - SW)		48	96	ns
t <sub>HFALL</sub>	High-side driver fall time			36	72	
V <sub>OH</sub>	High-level output voltage, HDRV	I <sub>HDRV</sub> = -0.1 A (HDRV - SW)	BOOST -1.5 V	BOOST -1.0 V		V
V <sub>OL</sub>	Low-level output voltage, HDRV	I <sub>HDRV</sub> = 0.1 A (HDRV - SW)			0.75	
V <sub>OH</sub>	High-level output voltage, LDRV	I <sub>LDRV</sub> = -0.1 A	BP10 -1.4 V	BP10 -1.0 V		
V <sub>OL</sub>	Low-level output voltage, LDRV	I <sub>LDRV</sub> = 0.1 A			0.5	
	Minimum controllable pulse width			100	150	ns
<b>SS/SD SHUTDOWN</b>						
V <sub>SD</sub>	Shutdown threshold voltage	Outputs off	90	125	150	mV
V <sub>EN</sub>	Device active threshold voltage		190	210	245	
<b>BOOST REGULATOR</b>						
V <sub>BOOST</sub>	Output voltage	V <sub>IN</sub> = 12.0 V	19.5	20.5	21.5	V
<b>SW NODE</b>						
I <sub>LEAK</sub>	Leakage current <sup>(1)</sup>				25	μA
<b>THERMAL SHUTDOWN</b>						
T <sub>SD</sub>	Shutdown temperature <sup>(1)</sup>			165		°C
	Hysteresis <sup>(1)</sup>			20		
<b>UVLO</b>						
	Input voltage UVLO threshold		8.45	8.75	9.10	V
	Input voltage UVLO hysteresis			1.0		

(1) Ensured by design. Not production tested.

**TERMINAL FUNCTIONS**

TERMINAL NAME	NO.	I/O	DESCRIPTION
BOOST	14	O	Gate drive voltage for the high side N-channel MOSFET. The BOOST voltage is 9 V greater than the input voltage. A 0.1- $\mu$ F ceramic capacitor should be connected from this pin to the SW pin.
BP5	3	O	5-V reference. This pin should be bypassed to ground with a 0.1- $\mu$ F ceramic capacitor. This pin may be used with an external dc load of 1 mA or less.
BP10	11	O	10-V reference used for gate drive of the N-channel synchronous rectifier. This pin should be bypassed by a 1- $\mu$ F ceramic capacitor. This pin may be used with an external dc load of 1 mA or less.
COMP	8	O	Output of the error amplifier, input to the PWM comparator. A feedback network is connected from this pin to the VFB pin to compensate the overall loop. The comp pin is internally clamped above the peak of the ramp to improve large signal transient response.
HDRV	13	O	Floating gate drive for the high-side N-channel MOSFET. This pin switches from BOOST (MOSFET on) to SW (MOSFET off).
ILIM	16	I	Current limit pin, used to set the overcurrent threshold. An internal current sink from this pin to ground sets a voltage drop across an external resistor connected from this pin to VCC. The voltage on this pin is compared to the voltage drop (VIN –SW) across the high side MOSFET during conduction.
EA_REF	4	I	Non-inverting input to the error amplifier and used as the reference for the feedback loop.
LDRV	10	O	Gate drive for the N-channel synchronous rectifier. This pin switches from BP10 (MOSFET on) to ground (MOSFET off).
PGND	9	–	Power ground reference for the device. There should be a low-impedance path from this pin to the source(s) of the lower MOSFET(s).
RT	2	I	A resistor is connected from this pin to ground to set the internal oscillator and switching frequency.
SGND	5	–	Signal ground reference for the device.
SS/SD	6	I	Soft-start programming pin. A capacitor connected from this pin to ground programs the soft-start time. The capacitor is charged with an internal current source of 2.3 $\mu$ A. The resulting voltage ramp on the SS pin is used as a second non-inverting input to the error amplifier. Output voltage regulation is controlled by the SS voltage ramp until the voltage on the SS pin reaches the internal reference voltage of 0.7 V. Pulling this pin low disables the controller.
SW	12	I	This pin is connected to the switched node of the converter and used for overcurrent sensing.
SYNC	1	I	Synchronization input for the device. This pin can be used to synchronize the oscillator to an external master frequency. If synchronization is not used, connect this pin to SGND.
VFB	7	I	Inverting input to the error amplifier. In normal operation the voltage on this pin is equal to the EA_REF reference voltage.
VIN	15	I	Supply voltage for the device.

FUNCTIONAL BLOCK DIAGRAM



## APPLICATION INFORMATION

The TPS40052 allows the user to optimize the PWM controller to the specific application.

The TPS40052 is the controller of choice for synchronous buck designs, the output of which is required to track another voltage. It has two quadrant operation and can source or sink output current, providing the best transient response.

### SW NODE RESISTOR AND DIODE

The SW node of the converter will be negative during the *dead time* when both the upper and lower MOSFETs are off. The magnitude of this negative voltage is dependent on the lower MOSFET body diode and the output current which flows during this dead time. This negative voltage could affect the operation of the controller, especially at low input voltages.

Therefore, a resistor ( 3.3  $\Omega$  to 4.7  $\Omega$ ) and Schottky diode must be placed between the lower MOSFET drain and pin 12, SW, of the controller as shown in Figure 10. The Schottky diode must have a voltage rating to accommodate the input voltage and ringing on the SW node of the converter. A 30-V Schottky such as a BAT54 or a 40-V Schottky such as a Zetex ZHCS400 or Vishay SD103AWS are adequate. These components are shown in Figure 10 as Rsw and D2.

### SETTING THE SWITCHING FREQUENCY (PROGRAMMING THE CLOCK OSCILLATOR)

The TPS40052 has independent clock oscillator and ramp generator circuits. The clock oscillator serves as the master clock to the ramp generator circuit. The switching frequency,  $f_{SW}$  in kHz, of the clock oscillator is set by a single resistor ( $R_T$ ) to ground. The clock frequency is related to  $R_T$ , in k $\Omega$  by equation (1).

$$R_T = \left( \frac{1}{f_{SW} \times 17.82 \times 10^{-6}} - 23 \right) \text{ k}\Omega \quad (1)$$

### UVLO OPERATION

The TPS40052 uses fixed UVLO protection. The fixed UVLO monitors the input voltage. The UVLO circuit holds the soft-start low until the input voltage has exceeded the undervoltage threshold.

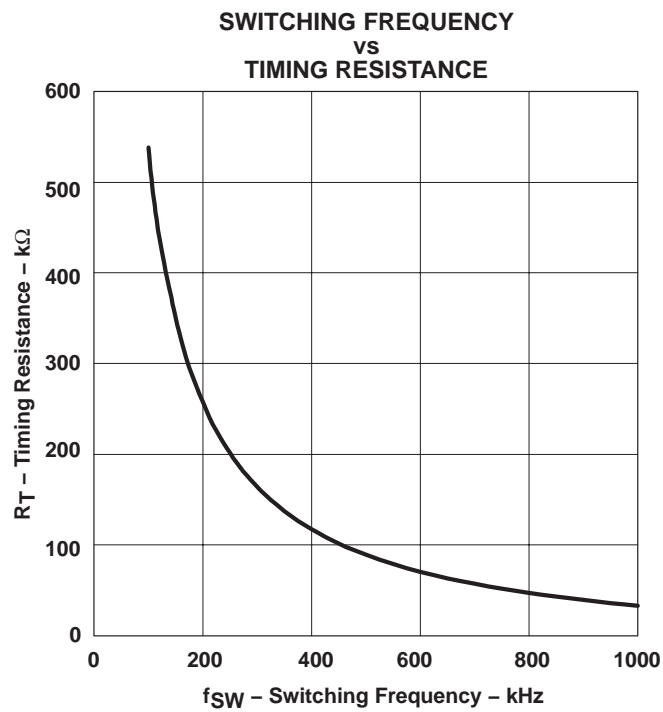


Figure 1

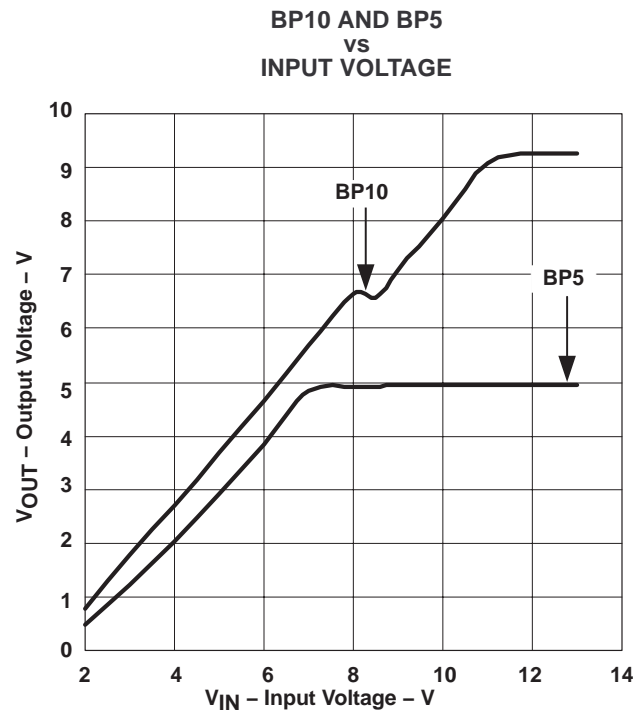


Figure 2

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## APPLICATION INFORMATION

### BP5 AND BP10 INTERNAL VOLTAGE REGULATORS

Start-up characteristics of the BP5 and BP10 regulators are shown in Figure 2. Slight variations in the BP5 occurs dependent upon the switching frequency. Variation in the BP10 regulation characteristics is also based on the load presented by switching the external MOSFETs.

### SELECTING THE INDUCTOR VALUE

The inductor value determines the magnitude of ripple current in the output capacitors as well as the load current at which the converter enters discontinuous mode. Too large an inductance results in lower ripple current but is physically larger for the same load current. Too small an inductance results in larger ripple currents and a greater number of (or more expensive output capacitors for) the same output ripple voltage requirement. A good compromise is to select the inductance value such that the converter doesn't enter discontinuous mode until the load approximated somewhere between 10% and 30% of the rated output. The inductance value is described in equation (2).

$$L = \frac{(V_{IN} - V_O) \times V_O}{V_{IN} \times \Delta I \times f_{SW}} \quad (\text{Henries}) \quad (2)$$

where:

- $V_O$  is the output voltage
- $\Delta I$  is the peak-to-peak inductor current

### CALCULATING THE OUTPUT CAPACITANCE

The output capacitance depends on the output ripple voltage requirement, output ripple current, as well as any output voltage deviation requirement during a load transient.

The output ripple voltage is a function of both the output capacitance and capacitor ESR. The worst case output ripple is described in equation (3).

$$\Delta V = \Delta I \left[ \text{ESR} + \left( \frac{1}{8 \times C_O \times f_{SW}} \right) \right] V_{P-P} \quad (3)$$

The output ripple voltage is typically between 90% and 95% due to the ESR component.

The output capacitance requirement typically increases in the presence of a load transient requirement. During a step load, the output capacitance must provide energy to the load (light to heavy load step) or absorb excess inductor energy (heavy to light load step) while maintaining the output voltage within acceptable limits. The amount of capacitance depends on the magnitude of the load step, the speed of the loop and the size of the inductor.

**APPLICATION INFORMATION**

Stepping the load from a heavy load to a light load results in an output overshoot. Excess energy stored in the inductor must be absorbed by the output capacitance. The energy stored in the inductor is described in equation (4).

$$E_L = \frac{1}{2} \times L \times I^2 \text{ (Joules)} \tag{4}$$

where:

$$I^2 = \left[ (I_{OH})^2 - (I_{OL})^2 \right] \text{ ((Amperes)^2)} \tag{5}$$

where:

- $I_{OH}$  is the output current under heavy load conditions
- $I_{OL}$  is the output current under light load conditions

Energy in the capacitor is described in equation (6).

$$E_C = \frac{1}{2} \times C \times V^2 \text{ (Joules)} \tag{6}$$

where:

$$V^2 = \left[ (V_f)^2 - (V_i)^2 \right] \text{ (Volts^2)} \tag{7}$$

where:

- $V_f$  is the final peak capacitor voltage
- $V_i$  is the initial capacitor voltage

Substituting equation (5) into equation (4), then substituting equation (7) into equation (6), then setting equation (6) equal to equation (4), and then solving for  $C_O$  yields the capacitance described in equation (8).

$$C_O = \frac{L \times \left[ (I_{OH})^2 - (I_{OL})^2 \right]}{\left[ (V_f)^2 - (V_i)^2 \right]} \text{ (Farads)} \tag{8}$$

## APPLICATION INFORMATION

### PROGRAMMING SOFT START

TPS40052 uses a closed-loop approach to ensure a controlled ramp on the output during start-up. Soft-start is programmed by charging an external capacitor ( $C_{SS}$ ) via an internally generated current source. The voltage on  $C_{SS}$  is fed into a separate non-inverting input to the error amplifier (in addition to FB and EA\_REF). The loop is closed on the lower of the  $C_{SS}$  voltage or the external reference voltage EA\_REF. Once the  $C_{SS}$  voltage rises above the external reference voltage, regulation is based on the external reference. To ensure a controlled ramp-up of the output voltage the soft-start time should be greater than the L- $C_O$  time constant as described in equation (9).

$$t_{START} \geq 2\pi \times \sqrt{L \times C_O} \quad (\text{seconds}) \quad (9)$$

There is a direct correlation between  $t_{START}$  and the input current required during start-up. The faster  $t_{START}$ , the higher the input current required during start-up. This relationship is describe in more detail in the section titled, *Programming the Current Limit* which follows. The soft-start capacitance,  $C_{SS}$ , is described in equation (10).

For applications in which the  $V_{IN}$  supply ramps up slowly, (typically between 50 ms and 100 ms) it may be necessary to increase the soft-start time to between approximately 2 ms and 5 ms to prevent nuisance UVLO tripping. The soft-start time should be longer than the time that the  $V_{IN}$  supply transitions between 8 V and 9 V.

$$C_{SS} = \frac{2.3 \mu\text{A}}{0.7 \text{ V}} \times t_{START} \quad (\text{Farads}) \quad (10)$$

### PROGRAMMING CURRENT LIMIT

The TPS40052 uses a two-tier approach for overcurrent protection. The first tier is a pulse-by-pulse protection scheme. Current limit is implemented on the high-side MOSFET by sensing the voltage drop across the MOSFET when the gate is driven high. The MOSFET voltage is compared to the voltage dropped across a resistor connected from VIN pin to the ILIM pin when driven by a constant current sink. If the voltage drop across the MOSFET exceeds the voltage drop across the ILIM resistor, the switching pulse is immediately terminated. The MOSFET remains off until the next switching cycle is initiated.

The second tier consists of a fault counter. The fault counter is incremented on an overcurrent pulse and decremented on a clock cycle without an overcurrent pulse. When the counter reaches seven (7) a restart is issued and seven soft-start cycles are initiated. Both the upper and lower MOSFETs are turned off during this period. The counter is decremented on each soft-start cycle. When the counter is decremented to zero, the PWM is re-enabled. If the fault has been removed the output starts up normally. If the output is still present the counter counts seven overcurrent pulses and re-enters the second-tier fault mode. See Figure 3 for typical overcurrent protection waveforms.

The minimum current limit setpoint ( $I_{LIM}$ ) depends on  $t_{START}$ ,  $C_O$ ,  $V_O$ , and the load current at turn-on ( $I_L$ ).

$$I_{LIM} = \left[ \frac{(C_O \times V_O)}{t_{START}} \right] + I_L \quad (\text{Amperes}) \quad (11)$$

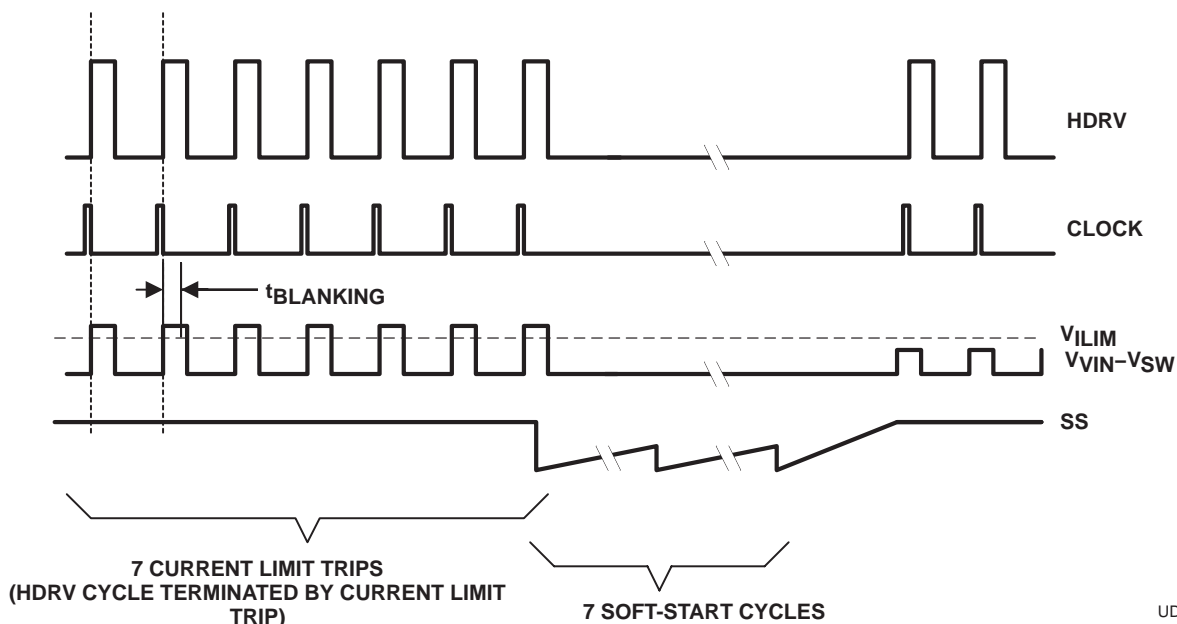
APPLICATION INFORMATION

The current limit programming resistor ( $R_{ILIM}$ ) is calculated using equation (12). Care must be taken in choosing the values used for  $V_{OS}$  and  $I_{SINK}$  in the equation. In order to ensure the output current at the overcurrent level, the minimum value of  $I_{SINK}$  and the maximum value of  $V_{OS}$  must be used.

$$R_{ILIM} = \frac{I_{OC} \times R_{DS(on)[max]}}{I_{SINK}} + \frac{V_{OS}}{I_{SINK}} \quad (\Omega) \tag{12}$$

where:

- $I_{SINK}$  is the current into the ILIM pin and is 8.6  $\mu A$ , minimum
- $I_{OC}$  is the overcurrent setpoint which is the DC output current plus one-half of the peak inductor current
- $V_{OS}$  is the overcurrent comparator offset and is 30 mV, maximum



UDG-02136

Figure 3. Typical Current Limit Protection Waveforms

## APPLICATION INFORMATION

### SYNCHRONIZING TO AN EXTERNAL SUPPLY

The TPS40052 can be synchronized to an external clock through the SYNC pin. Synchronization occurs on the falling edge of the SYNC signal. The synchronization frequency should be in the range of 20% to 30% higher than its programmed free-run frequency. The clock frequency at the SYNC pin replaces the master clock generated by the oscillator circuit. Pulling the SYNC pin low programs the TPS40052 to freely run at the frequency programmed by  $R_T$ .

The higher synchronization must be factored in when programming the PWM ramp generator circuit. If the PWM ramp is interrupted by the SYNC pulse, a UVLO condition is declared and the PWM becomes disabled. Typically this is of concern under low-line conditions only. In any case,  $R_{KFF}$  needs to be adjusted for the higher switching frequency. In order to specify the correct value for  $R_{KFF}$  at the synchronizing frequency, calculate a 'dummy' value for  $R_T$  that would cause the oscillator to run at the synchronizing frequency. Do not use this value of  $R_T$  in the design.

$$R_{T(\text{dummy})} = \left( \frac{1}{f_{\text{SYNC}} \times 17.82 \times 10^{-6}} - 17 \right) \text{ k}\Omega \quad (13)$$

Use the value of  $R_{T(\text{dummy})}$  to calculate the value for  $R_{KFF}$ .

$$R_{KFF} = (V_{\text{IN}(\text{min})} - 3.5 \text{ V}) \times (58.14 \times R_{T(\text{dummy})} + 1340) \Omega \quad (14)$$

This value of  $R_{KFF}$  ensures that UVLO is not engaged when operating at the synchronization frequency.

- $R_{T(\text{dummy})}$  is in  $\text{k}\Omega$

### LOOP COMPENSATION

Voltage-mode buck-type converters are typically compensated using Type III networks. Since the TPS40052 includes no voltage feedforward control, the gain of the PWM modulator must be included. The modulator gain is described in Figure 4.

$$A_{\text{MOD}} = \frac{V_{\text{IN}}}{V_{\text{S}}} \quad \text{or} \quad A_{\text{MOD}(\text{dB})} = 20 \times \log \left( \frac{V_{\text{IN}}}{V_{\text{S}}} \right) \quad (15)$$

Duty cycle,  $D$ , varies from 0 to 1 as the control voltage,  $V_C$ , varies from the minimum ramp voltage to the maximum ramp voltage,  $V_S$ . Also, for a synchronous buck converter,  $D = V_O / V_{\text{IN}}$ . To get the control voltage to output voltage modulator gain in terms of the input voltage and ramp voltage,

$$D = \frac{V_O}{V_{\text{IN}}} = \frac{V_C}{V_S} \quad \text{or} \quad \frac{V_O}{V_C} = \frac{V_{\text{IN}}}{V_S} \quad (16)$$

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**APPLICATION INFORMATION**
**Calculate the Poles and Zeros**

For a buck converter using voltage mode control there is a double pole due to the output L-C<sub>O</sub>. The double pole is located at the frequency calculated in equation (17).

$$f_{LC} = \frac{1}{2\pi \times \sqrt{L \times C_O}} \quad (\text{Hertz}) \quad (17)$$

There is also a zero created by the output capacitance, C<sub>O</sub>, and its associated ESR. The ESR zero is located at the frequency calculated in equation (18).

$$f_z = \frac{1}{2\pi \times \text{ESR} \times C_O} \quad (\text{Hertz}) \quad (18)$$

Calculate the value of R<sub>BIAS</sub> to set the output voltage, V<sub>OUT</sub>.

$$R_{BIAS} = \frac{V_{EA\_REF} \times R1}{V_{OUT} - V_{EA\_REF}} \quad \Omega \quad (19)$$

The maximum crossover frequency (0 dB loop gain) is calculated in equation (20).

$$f_c = \frac{f_{SW}}{4} \quad (\text{Hertz}) \quad (20)$$

Typically, f<sub>c</sub> is selected to be close to the midpoint between the L-C<sub>O</sub> double pole and the ESR zero. At this frequency, the control to output gain has a -2 slope (-40 dB/decade), while the Type III topology has a +1 slope (20 dB/decade), resulting in an overall closed loop -1 slope (-20 dB/decade).

Figure 5 shows the modulator gain, L-C filter, output capacitor ESR zero, and the resulting response to be compensated.

APPLICATION INFORMATION

PWM MODULATOR RELATIONSHIPS

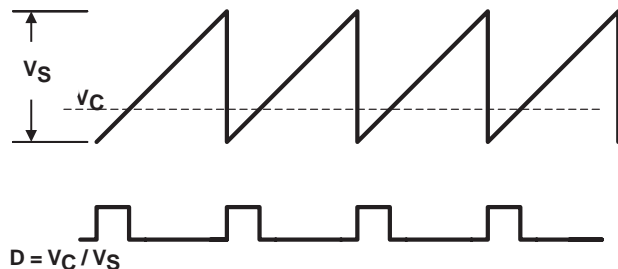


Figure 4

MODULATOR GAIN  
vs  
SWITCHING FREQUENCY

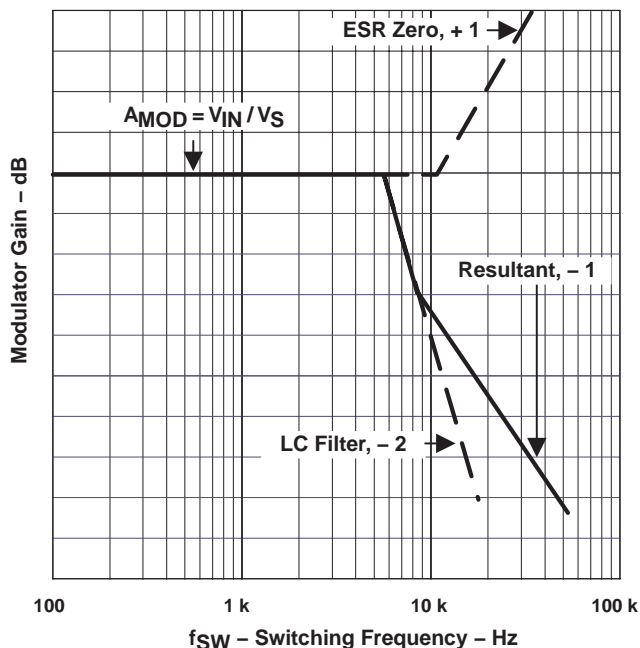
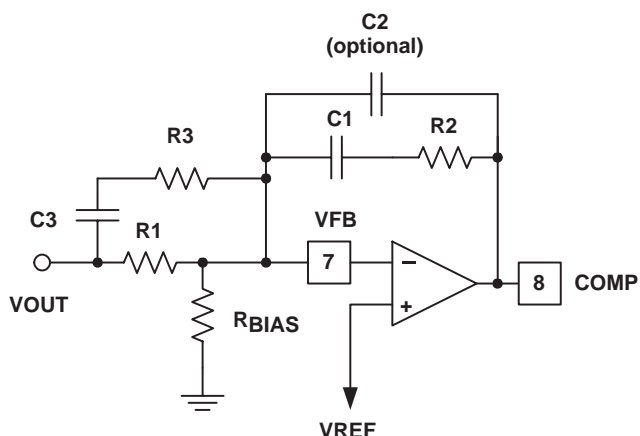


Figure 5

A Type III topology, shown in Figure 6, has two zero-pole pairs in addition to a pole at the origin. The gain and phase boost of a Type III topology is shown in Figure 7. The two zeros are used to compensate the L-C<sub>O</sub> double pole and provide phase boost. The double pole is used to compensate for the ESR zero and provide controlled gain roll-off. In many cases the second pole can be eliminated and the amplifier's gain roll-off used to roll-off the overall gain at higher frequencies.



UDG-03099

Figure 6. Type III Compensation Configuration

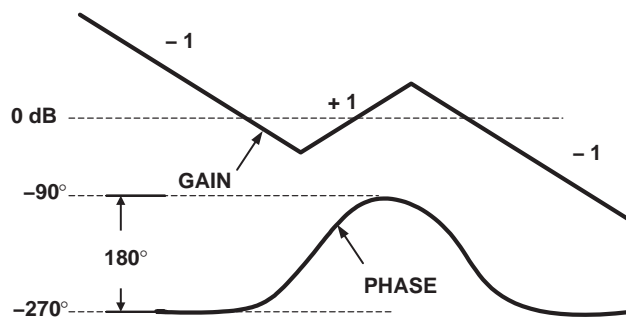


Figure 7. Type III Compensation Gain and Phase

**APPLICATION INFORMATION**

The poles and zeros for a type III network are described in equations (21).

$$f_{z1} = \frac{1}{2\pi \times R2 \times C1} \text{ (Hertz)} \quad f_{z2} = \frac{1}{2\pi \times R1 \times C3} \text{ (Hertz)} \tag{21}$$

$$f_{p1} = \frac{1}{2\pi \times R2 \times C2} \text{ (Hertz)} \quad f_{p2} = \frac{1}{2\pi \times R3 \times C3} \text{ (Hertz)}$$

The value of R1 is somewhat arbitrary, but influences other component values. A value between 50kΩ and 100kΩ usually yields reasonable values.

The unity gain frequency is described in equation (22)

$$f_c = \frac{1}{2\pi \times R1 \times C2 \times G} \text{ (Hertz)} \tag{22}$$

where G is the reciprocal of the modulator gain at f<sub>c</sub>.

The modulator gain as a function of frequency at f<sub>c</sub>, is described in equation (23).

$$AMOD(f) = AMOD \times \left(\frac{f_{LC}}{f_c}\right)^2 \text{ and } G = \frac{1}{AMOD(f)} \tag{23}$$

**Minimum Load Resistance**

Care must be taken not to load down the output of the error amplifier with the feedback resistor, R2, that is too small. The error amplifier has a finite output source and sink current which must be considered when sizing R2. Too small a value does not allow the output to swing over its full range.

$$R2_{(MIN)} = \frac{V_{C(max)}}{I_{SOURCE(min)}} = \frac{3.45 \text{ V}}{2 \text{ mA}} = 1725 \ \Omega \tag{24}$$

**CALCULATING THE BOOST AND BP10 BYPASS CAPACITOR**

The BOOST capacitance provides a local, low impedance source for the high-side driver. The BOOST capacitor should be a good quality, high-frequency capacitor. The size of the bypass capacitor depends on the total gate charge of the MOSFET and the amount of droop allowed on the bypass capacitor. The BOOST capacitance is described in equation (25).

$$C_{BOOST} = \frac{Q_g}{\Delta V} \text{ (Farads)} \tag{25}$$

The 10-V reference pin, BP10V needs to provide energy for both the synchronous MOSFET and the high-side MOSFET via the BOOST capacitor. Neglecting any efficiency penalty, the BP10V capacitance is described in equation (26).

$$C_{BP10} = \frac{(Q_{gHS} + Q_{gSR})}{\Delta V} \text{ (Farads)} \tag{26}$$

## APPLICATION INFORMATION

### dv/dt Induced Turn-on

MOSFETs are susceptible to dv/dt turn-on particularly in high-voltage ( $V_{DS}$ ) applications. The turn-on is caused by the capacitor divider that is formed by  $C_{GD}$  and  $C_{GS}$ . High dv/dt conditions and drain-to-source voltage, on the MOSFET causes current flow through  $C_{GD}$  and causes the gate-to-source voltage to rise. If the gate-to-source voltage rises above the MOSFET threshold voltage, the MOSFET turns on, resulting in large shoot-through currents. Therefore, the SR MOSFET should be chosen so that the  $C_{GD}$  capacitance is smaller than the  $C_{GS}$  capacitance.

### High Side MOSFET Power Dissipation

The power dissipated in the external high-side MOSFET is comprised of conduction and switching losses. The conduction losses are a function of the  $I_{RMS}$  current through the MOSFET and the  $R_{DS(on)}$  of the MOSFET. The high-side MOSFET conduction losses are defined by equation (27).

$$P_{COND} = (I_{RMS})^2 \times R_{DS(on)} \times (1 + TC_R \times [T_J - 25]) \quad (\text{Watts}) \quad (27)$$

where:

- $TC_R$  is the temperature coefficient of the MOSFET  $R_{DS(on)}$

The  $TC_R$  varies depending on MOSFET technology and manufacturer but is typically ranges between .0035 ppm/°C and .010 ppm/°C.

The  $I_{RMS}$  current for the high side MOSFET is described in equation (28).

$$I_{RMS} = I_O \times \sqrt{d} \quad (\text{Amperes}_{RMS}) \quad (28)$$

The switching losses for the high-side MOSFET are described in equation (29).

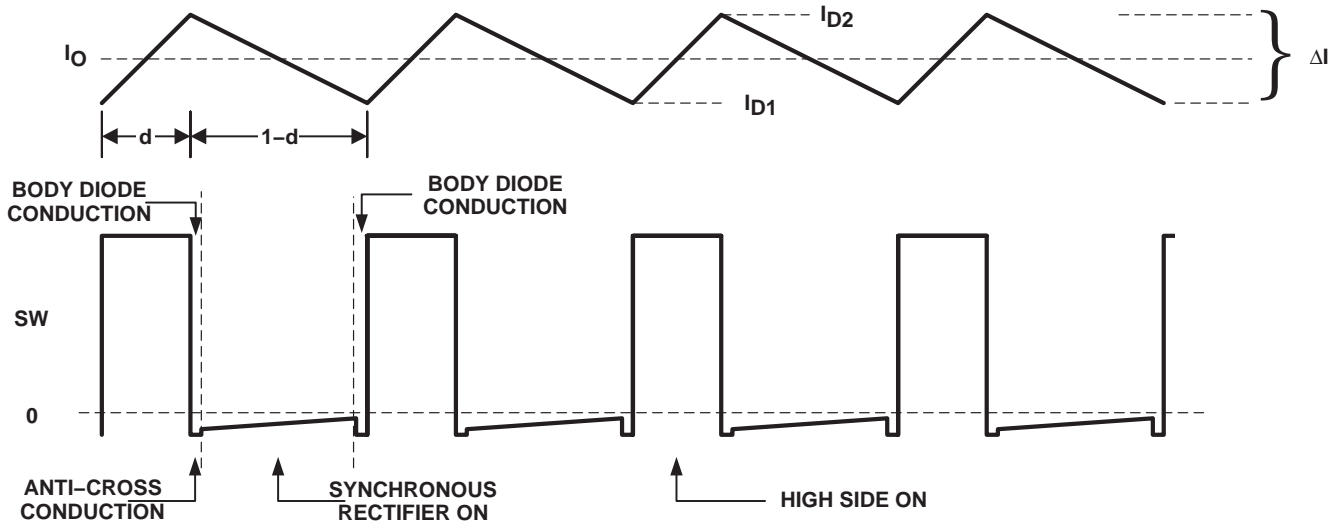
$$P_{SW(fsw)} = (V_{IN} \times I_{OUT} \times t_{SW}) \times f_{SW} \quad (\text{Watts}) \quad (29)$$

where:

- $I_O$  is the DC output current
- $t_{SW}$  is the switching rise time, typically < 20 ns
- $f_{SW}$  is the switching frequency

Typical switching waveforms are shown in Figure 8.

APPLICATION INFORMATION



UDG-02139

Figure 8. Inductor Current and SW Node Waveforms

The maximum allowable power dissipation in the MOSFET is determined by equation (30).

$$P_T = \frac{(T_J - T_A)}{\theta_{JA}} \text{ (Watts)} \tag{30}$$

where:

$$P_T = P_{COND} + P_{SW(fsw)} \text{ (Watts)} \tag{31}$$

and  $\theta_{JA}$  is the package thermal impedance.

Synchronous Rectifier MOSFET Power Dissipation

The power dissipated in the synchronous rectifier MOSFET is comprised of three components:  $R_{DS(on)}$  conduction losses, body diode conduction losses, and reverse recovery losses.  $R_{DS(on)}$  conduction losses can be found using equation (27) and the RMS current through the synchronous rectifier MOSFET is described in equation (32).

$$I_{RMS} = I_O \times \sqrt{1 - d} \text{ (Amperes}_{RMS}) \tag{32}$$

The body-diode conduction losses are due to forward conduction of the body diode during the anti-cross conduction delay time. The body diode conduction losses are described by equation (33).

$$P_{DC} = 2 \times I_O \times V_F \times t_{DELAY} \times f_{SW} \text{ (Watts)} \tag{33}$$

where:

- $V_F$  is the body diode forward voltage
- $t_{DELAY}$  is the total delay time just before the SW node rises.

## APPLICATION INFORMATION

The 2-multiplier is used because the body-diode conducts twice each cycle (once on the rising edge and once on the falling edge). The reverse recovery losses are due to the time it takes for the body diode to recovery from a forward bias to a reverse blocking state. The reverse recovery losses are described in equation (34).

$$P_{RR} = 0.5 \times Q_{RR} \times V_{IN} \times f_{SW} \text{ (Watts)} \quad (34)$$

where:

- $Q_{RR}$  is the reverse recovery charge of the body diode

The total synchronous rectifier MOSFET power dissipation is described in equation (35).

$$P_{SR} = P_{DC} + P_{RR} + P_{COND} \text{ (Watts)} \quad (35)$$

## TPS40052 POWER DISSIPATION

The power dissipation in the TPS40052 is largely dependent on the MOSFET driver currents and the input voltage. The driver current is proportional to the total gate charge,  $Q_g$ , of the external MOSFETs. Driver power (neglecting external gate resistance, refer to [2] can be calculated from equation (36).

$$P_D = Q_g \times V_{DR} \times f_{SW} \text{ (Watts)} \quad (36)$$

And the total power dissipation in the TPS40052, assuming the same MOSFET is selected for both the high-side and synchronous rectifier is described in equation (37).

$$P_T = \left( \frac{2 \times P_D}{V_{DR}} + I_Q \right) \times V_{IN} \text{ (Watts)} \quad (37)$$

or

$$P_T = (2 \times Q_g \times f_{SW} + I_Q) \times V_{IN} \text{ (Watts)} \quad (38)$$

where:

- $I_Q$  is the quiescent operating current (neglecting drivers)

The maximum power capability of the device's PowerPad package is dependent on the layout as well as air flow. The thermal impedance from junction to air, assuming 2 oz. copper trace and thermal pad with solder and no air flow.

$$\theta_{JA} = 36.51^\circ\text{C/W}$$

The maximum allowable package power dissipation is related to ambient temperature by equation (30). Substituting equation (38) into equation (37) and solving for  $f_{SW}$  yields the maximum operating frequency for the TPS4005x. The result is described in equation (39).

$$f_{SW} = \frac{\left( \left[ \frac{(T_J - T_A)}{(\theta_{JA} \times V_{DD})} \right] - I_Q \right)}{(2 \times Q_g)} \text{ (Hz)} \quad (39)$$

LAYOUT CONSIDERATIONS

The PowerPAD™ package

The PowerPAD package provides low thermal impedance for heat removal from the device. The PowerPAD derives its name and low thermal impedance from the large bonding pad on the bottom of the device. For maximum thermal performance, the circuit board must have an area of solder-tinned-copper underneath the package. The dimensions of this area depends on the size of the PowerPAD package. For a 16-pin TSSOP (PWP) package the area is 5 mm x 3.4 mm [3].

Thermal vias connect this area to internal or external copper planes and should have a drill diameter sufficiently small so that the via hole is effectively plugged when the barrel of the via is plated with copper. This plug is needed to prevent wicking the solder away from the interface between the package body and the solder-tinned area under the device during solder reflow. Drill diameters of 0.33 mm (13 mils) works well when 1-oz copper is plated at the surface of the board while simultaneously plating the barrel of the via. If the thermal vias are not plugged when the copper plating is performed, then a solder mask material should be used to cap the vias with a diameter equal to the via diameter of 0.1 mm minimum. This capping prevents the solder from being wicked through the thermal vias and potentially creating a solder void under the package. Refer to *PowerPAD Thermally Enhanced Package*[3] and the mechanical illustration at the end of this document for more information on the PowerPAD package.

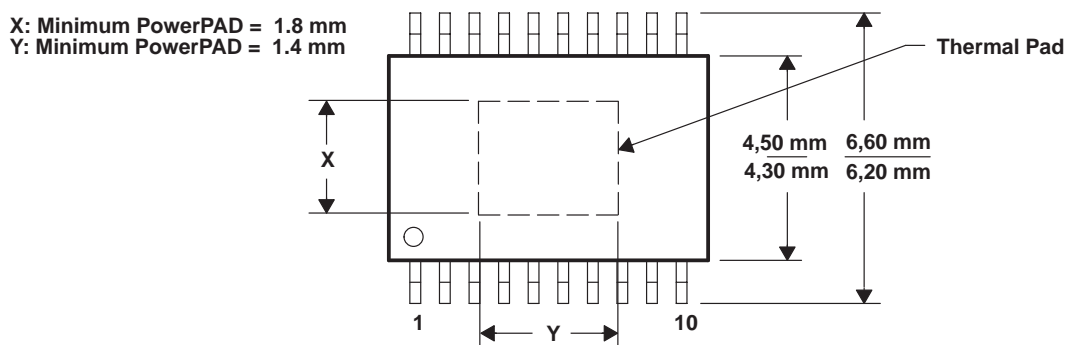


Figure 9. PowerPAD Dimensions

MOSFET Packaging

MOSFET package selection depends on MOSFET power dissipation and the projected operating conditions. In general, for a surface-mount applications, the DPAK style package provides the lowest thermal impedance ( $\theta_{JA}$ ) and, therefore, the highest power dissipation capability. However, the effectiveness of the DPAK depends on proper layout and thermal management. The  $\theta_{JA}$  specified in the MOSFET data sheet refers to a given copper area and thickness. In most cases, a lowest thermal impedance of 40°C/W requires one square inch of 2-ounce copper on a G-10/FR-4 board. Lower thermal impedances can be achieved at the expense of board area. Please refer to the selected MOSFET's data sheet for more information regarding proper mounting.

## LAYOUT CONSIDERATIONS

### Grounding and Circuit Layout Considerations

The TPS4005x provides separate signal ground (SGND) and power ground (PGND) pins. It is important that circuit grounds are properly separated. Each ground should consist of a plane to minimize its impedance if possible. The high power *noisy* circuits such as the output, synchronous rectifier, MOSFET driver decoupling capacitor (BP10), and the input capacitor should be connected to PGND plane at the input capacitor.

Sensitive nodes such as the FB resistor divider,  $R_T$ , and ILIM should be connected to the SGND plane. The SGND plane should only make a single point connection to the PGND plane.

Component placement should ensure that bypass capacitors (BP10 and BP5) are located as close as possible to their respective power and ground pins. Also, sensitive circuits such as FB, RT and ILIM should not be located near high dv/dt nodes such as HDRV, LDRV, BOOST, and the switch node (SW).

The SW pin Schottky diode, D2 in Figure 10, should be placed close to the TPS40052 with short, wide traces to pins 9 and 12.

**DESIGN EXAMPLE**

- Input Voltage: 10 Vdc to 14.4 Vdc
- Output voltage: 1.25 V ±1% (1.2375 ≤ V<sub>O</sub> ≤ 1.2625)
- Output current: 8 A (maximum, steady state), 10 A (surge, 10ms duration, 10% duty cycle maximum)
- Output ripple: 33 mV<sub>P-P</sub> at 8 A
- Output load response: 0.1 V => 10% to 90% step load change, from 1 A to 7 A
- Operating temperature: –40°C to 85°C
- f<sub>SW</sub>=170 kHz

**1. Calculate maximum and minimum duty cycles**

$$d_{MIN} = \frac{V_{O(min)}}{V_{IN(max)}} = \frac{1.2375}{14.4} = 0.086 \quad d_{MAX} = \frac{V_{O(max)}}{V_{IN(min)}} = \frac{1.2625}{10} = 0.126 \tag{40}$$

**2. Select switching frequency**

The switching frequency is based on the minimum duty cycle ratio and the propagation delay of the current limit comparator. In order to maintain current limit capability, the on time of the upper MOSFET, t<sub>ON</sub>, must be greater than 400 ns (see Electrical Characteristics table). Therefore

$$\frac{V_{O(min)}}{V_{IN(max)}} = \frac{t_{ON}}{T_{SW}} \quad \text{or} \tag{41}$$

$$\frac{1}{T_{SW}} = f_{SW} = \left[ \frac{\left( \frac{V_{O(min)}}{V_{IN(max)}} \right)}{T_{ON}} \right] \tag{42}$$

Using 450 ns to provide margin,

$$f_{SW} = \frac{0.086}{450 \text{ ns}} = 191 \text{ kHz} \tag{43}$$

Since the oscillator can vary by 10%, decrease f<sub>SW</sub>, by 10%

$$f_{SW} = 0.9 \times 191 \text{ kHz} = 172 \text{ kHz}$$

and therefore choose a frequency of 170 kHz.

**3. Select ΔI**

In this case ΔI is chosen so that the converter enters discontinuous mode at 20% of nominal load.

$$\Delta I = I_O \times 2 \times 0.2 = 8 \times 2 \times 0.2 = 3.2 \text{ A} \tag{44}$$

## DESIGN EXAMPLE

### 4. Calculate the power losses

Power losses in the high-side MOSFET (Si7860DP) at 14.4-V<sub>IN</sub> where switching losses dominate can be calculated from equation (29).

$$I_{\text{RMS}} = I_{\text{O}} \times \sqrt{d} = 8 \times \sqrt{0.086} = 2.35 \text{ A} \quad (45)$$

substituting (28) into (27) yields

$$P_{\text{COND}} = 2.35^2 \times 0.008 \times (1 + 0.007 \times (150 - 25)) = 0.083 \text{ W} \quad (46)$$

and from equation (29), the switching losses can be determined.

$$P_{\text{SW}(f_{\text{sw}})} = (V_{\text{IN}} \times I_{\text{O}} \times t_{\text{SW}}) \times f_{\text{SW}} = 14.4 \text{ V} \times 8 \text{ A} \times 20 \text{ ns} \times 170 \text{ kHz} = 0.39 \text{ W} \quad (47)$$

The MOSFET junction temperature can be found by substituting equation (31) into equation (30)

$$T_{\text{J}} = (P_{\text{COND}} + P_{\text{SW}}) \times \theta_{\text{JA}} + T_{\text{A}} = (0.083 + 0.39) \times 40 + 85 = 90^{\circ}\text{C} \quad (48)$$

### 5. Calculate synchronous rectifier losses

The synchronous rectifier MOSFET has two loss components, conduction, and diode reverse recovery losses. The conduction losses are due to  $I_{\text{RMS}}$  losses as well as body diode conduction losses during the dead time associated with the anti-cross conduction delay.

The  $I_{\text{RMS}}$  current through the synchronous rectifier from (32)

$$I_{\text{RMS}} = I_{\text{O}} \times \sqrt{1 - d} = 8 \times \sqrt{1 - 0.126} = 7.48 \text{ A}_{\text{RMS}} \quad (49)$$

The synchronous MOSFET conduction loss from (27) is:

$$P_{\text{COND}} = 7.48^2 \times 0.008 \times (1 + 0.007(150 - 25)) = 0.83 \text{ W} \quad (50)$$

The body diode conduction loss from (33) is:

$$P_{\text{DC}} = 2 \times I_{\text{O}} \times V_{\text{FD}} \times t_{\text{DELAY}} \times f_{\text{SW}} = 2 \times 8.0 \text{ A} \times 0.8 \text{ V} \times 100 \text{ ns} \times 170 \text{ kHz} = 0.218 \quad (51)$$

The body diode reverse recovery loss from (34) is:

$$P_{\text{RR}} = 0.5 \times Q_{\text{RR}} \times V_{\text{IN}} \times f_{\text{SW}} = 0.5 \times 30 \text{ nC} \times 14.4 \text{ V} \times 170 \text{ kHz} = 0.037 \text{ W} \quad (52)$$

The total power dissipated in the synchronous rectifier MOSFET from (35) is:

$$P_{\text{SR}} = P_{\text{RR}} + P_{\text{COND}} + P_{\text{DC}} = 0.037 + 0.83 + 0.218 = 1.085 \text{ W} \quad (53)$$

The junction temperature of the synchronous rectifier at 85°C is:

$$T_{\text{J}} = P_{\text{SR}} \times \theta_{\text{JA}} + T_{\text{A}} = (1.085) \times 40 + 85 = 128^{\circ}\text{C} \quad (54)$$

In typical applications, paralleling the synchronous rectifier MOSFET with a Schottky rectifier increases the overall converter efficiency by approximately 2% due to the lower power dissipation during the body diode conduction and reverse recovery periods.

## DESIGN EXAMPLE

**6. Calculate the inductor value**

The inductor value is calculated from equation (2).

$$L = \frac{(14.4 - 1.25 \text{ V}) \times 1.25 \text{ V}}{14.4 \text{ V} \times 3.2 \text{ A} \times 170 \text{ kHz}} = 2.1 \mu\text{H} \quad (55)$$

A 2.9- $\mu\text{H}$  Coev DXM1306–2R9 or 2.6- $\mu\text{H}$  Panasonic ETQ–P6F2R9LFA can be used.

**7. Setting the switching frequency**

The clock frequency is set with a resistor ( $R_T$ ) from the RT pin to ground. The value of  $R_T$  can be found from equation (1), with  $f_{\text{SW}}$  in kHz.

$$R_T = \left( \frac{1}{f_{\text{SW}} \times 17.82 \times 10^{-6}} - 23 \right) \text{ k}\Omega = 307 \text{ k}\Omega \quad \therefore \text{ use } 309 \text{ k}\Omega \quad (56)$$

**8. Calculating the output capacitance ( $C_O$ )**

In this example the output capacitance is determined by the load response requirement of  $\Delta V = 0.1 \text{ V}$  for a 1 A to 7 A step load.  $C_O$  can be calculated using (8)

$$C_O = \frac{2.9 \mu \times \left( (8 \text{ A})^2 - (1 \text{ A})^2 \right)}{\left( (1.25)^2 - (1.15)^2 \right)} = 761 \mu\text{F} \quad (57)$$

Using (3) we can calculate the ESR required to meet the output ripple requirements.

$$33 \text{ mV} = 3.2 \text{ A} \left( \text{ESR} + \frac{1}{8 \times 761 \mu\text{F} \times 170 \text{ kHz}} \right) \quad (58)$$

$$\text{ESR} = 10.3 \text{ m}\Omega - 1.0 \text{ m}\Omega = 9.3 \text{ m}\Omega \quad (59)$$

For this design example two (2) Panasonic SP EEFUEOD471R capacitors, (2.0 V, 470  $\mu\text{F}$ , 12 m $\Omega$ ) are used.

**9. Calculate the soft-start capacitor ( $C_{\text{SS}}$ )**

This design requires a soft-start time ( $t_{\text{START}}$ ) of 1 ms.  $C_{\text{SS}}$  can be calculated on (10)

$$C_{\text{SS}} = \frac{2.3 \mu\text{A}}{0.7 \text{ V}} \times 1 \text{ ms} = 3.29 \text{ nF} = 3300 \text{ pF} \quad (60)$$

## DESIGN EXAMPLE

### 10. Calculate the current limit resistor ( $R_{ILIM}$ )

The current limit set point depends on  $t_{START}$ ,  $V_O$ ,  $C_O$  and  $I_{LOAD}$  at start-up as shown in equation (11). For this design,

$$I_{LIM} > \frac{940 \mu\text{F} \times 1.25 \text{ V}}{1 \text{ ms}} + 8.0 \text{ A} = 9.2 \text{ A} \quad (61)$$

For this design, set  $I_{LIM}$  for 11.0 A<sub>DC</sub> minimum. From equation (12), with  $I_{OC}$  equal to the DC output surge current plus one-half the ripple current of 3.2 A and  $R_{DS(on)}$  is increased 30% ( $1.3 * 0.008$ ) to allow for MOSFET heating.

$$R_{ILIM} = \frac{12.6 \text{ A} \times 0.0104 \Omega}{8.6 \mu\text{A}} + \frac{(0.03)}{8.6 \mu\text{A}} = 15.24 \text{ k}\Omega - 3.5 \text{ k}\Omega = 11.74 \text{ k}\Omega \cong 11.8 \Omega \quad (62)$$

### 11. Calculate loop compensation values

Calculate the DC modulator gain ( $A_{MOD}$ ) from equation (15)

$$A_{MOD} = \frac{12}{2} = 6.0 \quad A_{MOD(dB)} = 20 \times \log(6) = 15.6 \text{ dB} \quad (63)$$

Calculate the output filter L- $C_O$  poles and  $C_O$  ESR zeros from (17) and (18)

$$f_{LC} = \frac{1}{2\pi \sqrt{L \times C_O}} = \frac{1}{2\pi \sqrt{2.9 \mu\text{H} \times 940 \mu\text{F}}} = 3.05 \text{ kHz} \quad (64)$$

and

$$f_Z = \frac{1}{2\pi \times \text{ESR} \times C_O} = \frac{1}{2\pi \times 0.006 \times 940 \mu\text{F}} = 28.2 \text{ kHz} \quad (65)$$

Select the close-loop 0 dB crossover frequency,  $f_C$ . For this example  $f_C = 20 \text{ kHz}$ .

Select the double zero location for the Type III compensation network at the output filter double pole at 3.05 kHz.

Select the double pole location for the Type III compensation network at the output capacitor ESR zero at 28.2 kHz.

The amplifier gain at the crossover frequency of 20 kHz is determined by the reciprocal of the modulator gain  $A_{MOD}$  at the crossover frequency from equation (23).

$$A_{MOD(f)} = A_{MOD} \times \left( \frac{f_{LC}}{f_C} \right)^2 = 6 \times \left( \frac{3.05 \text{ kHz}}{20 \text{ kHz}} \right)^2 = 0.14 \quad (66)$$

And also from equation (23).

$$G = \frac{1}{A_{MOD(f)}} = \frac{1}{0.14} = 7.14 \quad (67)$$

Choose  $R1 = 100 \text{ k}\Omega$

**DESIGN EXAMPLE**

The poles and zeros for a type III network are described in equations (21) and (22).

$$f_{Z2} = \frac{1}{2\pi \times R1 \times C3} \therefore C3 = \frac{1}{2\pi \times 100 \text{ k}\Omega \times 3.05 \text{ kHz}} = 522 \text{ pF, choose 560 pF} \tag{68}$$

$$f_{P2} = \frac{1}{2\pi \times R3 \times C3} \therefore R3 = \frac{1}{2\pi \times 560 \text{ pF} \times 28.2 \text{ kHz}} = 10.08 \text{ k}\Omega, \text{ choose } 10 \text{ k}\Omega \tag{69}$$

$$f_C = \frac{1}{2\pi \times R1 \times C2 \times G} \therefore C2 = \frac{1}{2\pi \times 100 \text{ k}\Omega \times 7.14 \times 20 \text{ kHz}} = 11.1 \text{ pF, choose } 10 \text{ pF} \tag{70}$$

$$f_{P1} = \frac{1}{2\pi \times R2 \times C2} \therefore R2 = \frac{1}{2\pi \times 10 \text{ pF} \times 28.2 \text{ kHz}} = 564 \text{ k}\Omega, \text{ choose } 562 \text{ k}\Omega \tag{71}$$

$$f_{Z1} = \frac{1}{2\pi \times R2 \times C1} \therefore C1 = \frac{1}{2\pi \times 562 \text{ k}\Omega \times 3.05 \text{ kHz}} = 92.9 \text{ pF, choose } 100 \text{ pF} \tag{72}$$

Calculate the value of R<sub>BIAS</sub> from equation (17) with R1 = 100 kΩ. Since the output of 1.25-V is within the EA\_REF input specification of 0.5 V to 1.5 V, an R<sub>BIAS</sub> resistor is not required.

**CALCULATING THE BOOST AND BP10V BYPASS CAPACITANCE**

The size of the bypass capacitor depends on the total gate charge of the MOSFET being used and the amount of droop allowed on the bypass cap. The BOOST capacitance for the Si7860DP, allowing for a 0.5 voltage droop on the BOOST pin from equation (25) is:

$$C_{\text{BOOST}} = \frac{Q_g}{\Delta V} = \frac{18 \text{ nC}}{0.5 \text{ V}} = 36 \text{ nF} \tag{73}$$

and the BP10V capacitance from (26) is

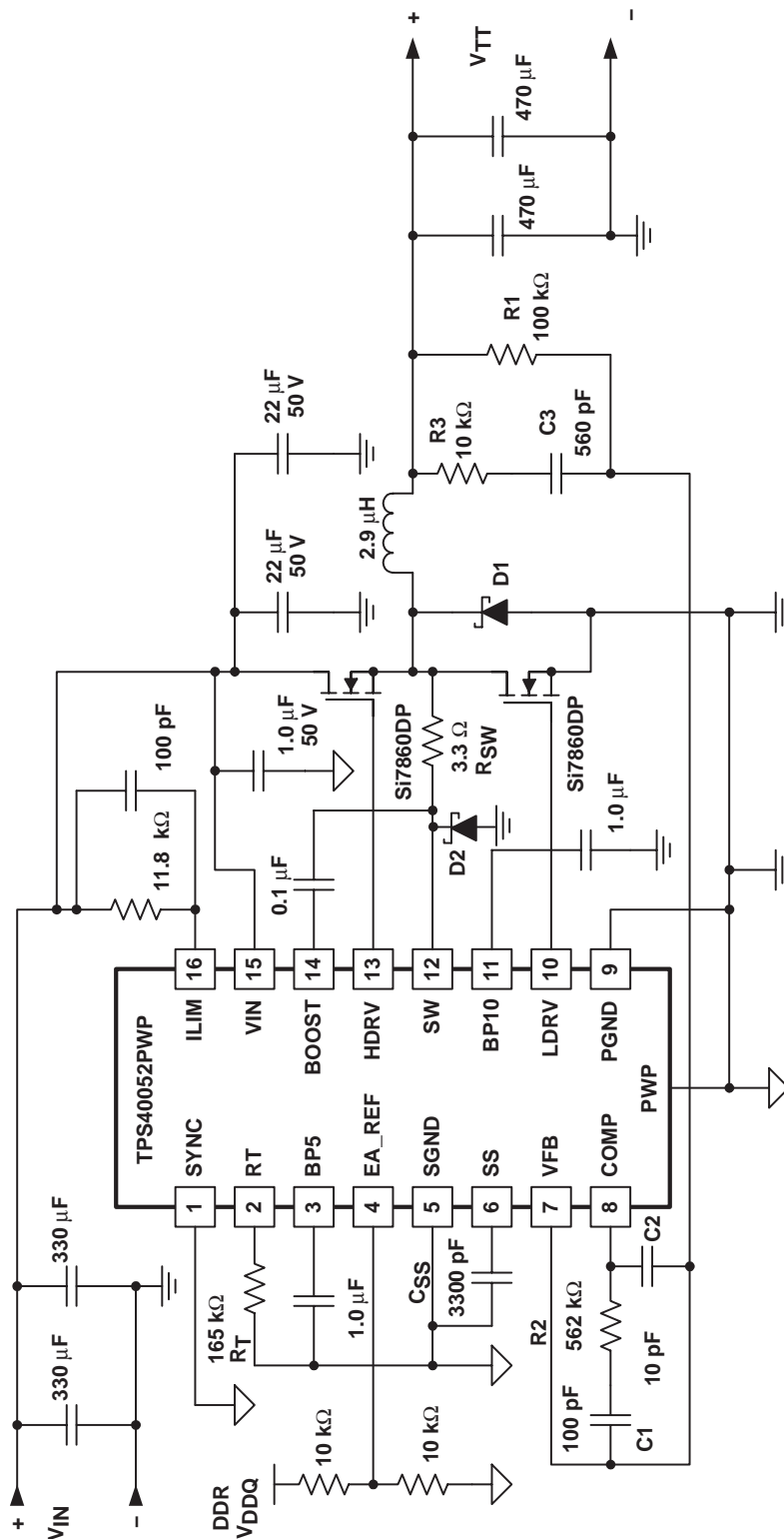
$$C_{\text{BP}(10 \text{ V})} = \frac{Q_{g\text{HS}} + Q_{g\text{SR}}}{\Delta V} = \frac{2 \times Q_g}{\Delta V} = \frac{36 \text{ nC}}{0.5 \text{ V}} = 72 \text{ nF} \tag{74}$$

For this application, a 0.1-μF capacitor is used for the BOOST bypass capacitor and a 1.0-μF capacitor is used for the BP10V bypass.

Figure 10 shows component selection for the 10-V to 14.4-V to 1.25-V at 8 A dc-to-dc converter specified in the design example.

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1. Balogh, Laszlo, *Design and Application Guide for High Speed MOSFET Gate Drive Circuits*, Texas Instruments/Unitrode Corporation, Power Supply Design Seminar, SEM-1400 Topic 2.
2. *PowerPAD Thermally Enhanced Package* Texas Instruments, Semiconductor Group, Technical Brief: TI Literature No. SLMA002



UDG-03100

Figure 10. 12-V to 1.25-V at 8-A DC-to-DC Converter (DDR) Design Example

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS40052PWP	NRND	Production	HTSSOP (PWP)   16	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	40052
TPS40052PWP.A	NRND	Production	HTSSOP (PWP)   16	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	40052

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

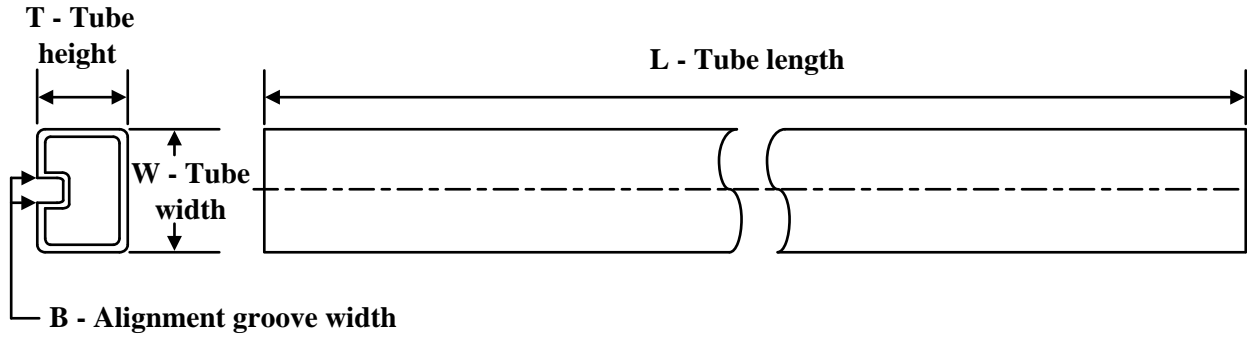
(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

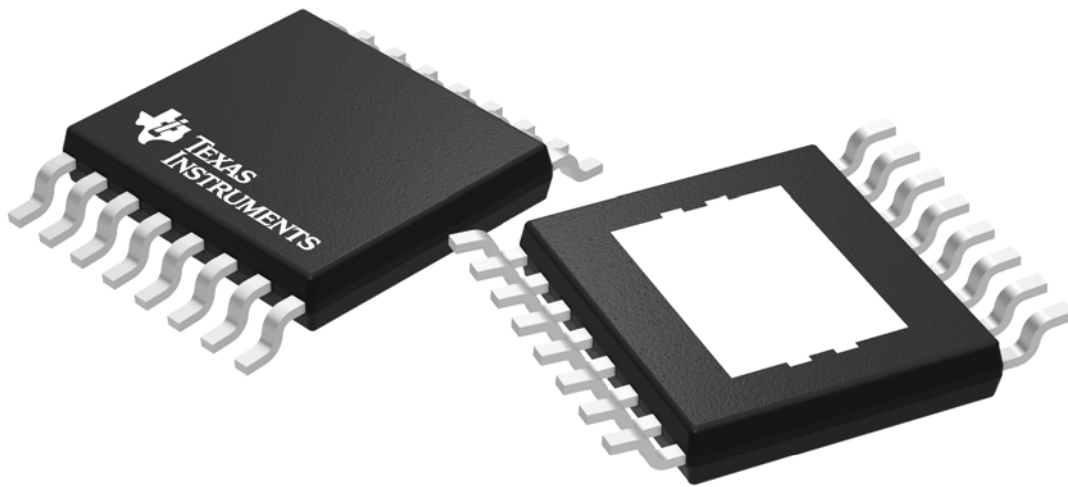
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**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
TPS40052PWP	PWP	HTSSOP	16	90	530	10.2	3600	3.5
TPS40052PWP.A	PWP	HTSSOP	16	90	530	10.2	3600	3.5



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

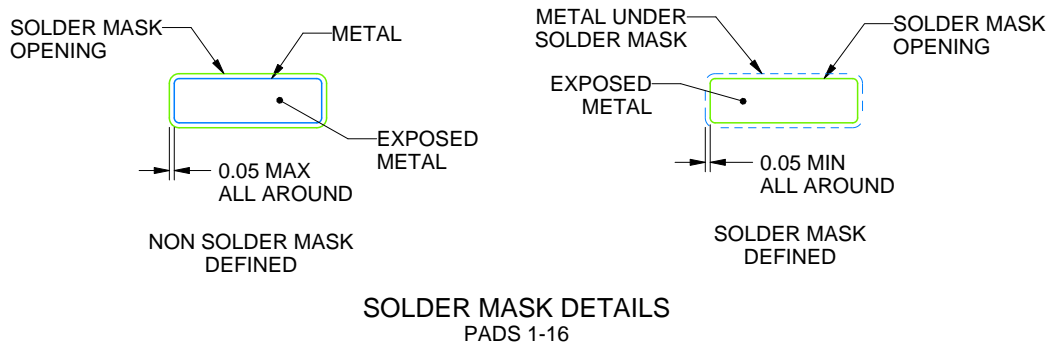
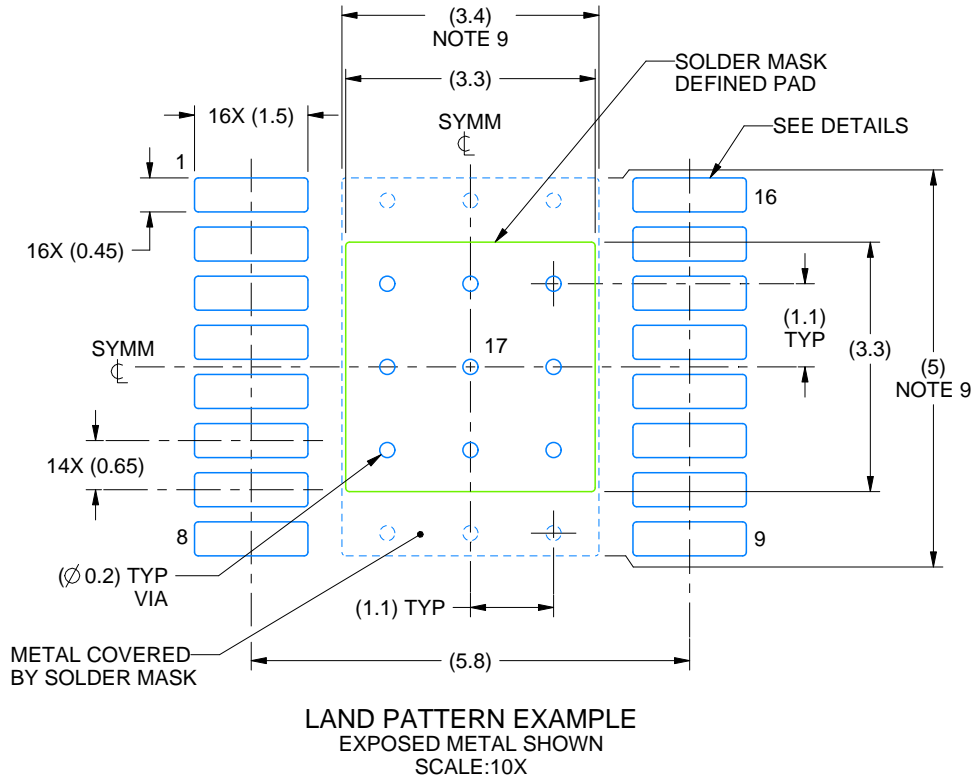


# EXAMPLE BOARD LAYOUT

PWP0016A

PowerPAD™ HTSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



4214868/A 02/2017

NOTES: (continued)

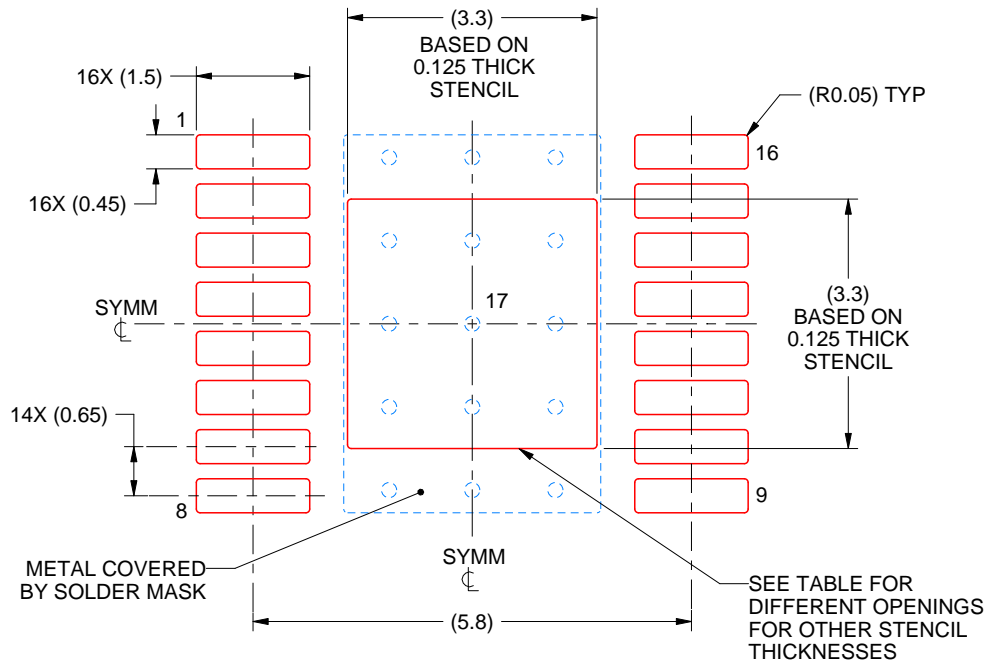
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 ([www.ti.com/lit/slma002](http://www.ti.com/lit/slma002)) and SLMA004 ([www.ti.com/lit/slma004](http://www.ti.com/lit/slma004)).
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

PWP0016A

PowerPAD™ HTSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



SOLDER PASTE EXAMPLE  
EXPOSED PAD  
100% PRINTED SOLDER COVERAGE BY AREA  
SCALE:10X

STENCIL THICKNESS	SOLDER STENCIL OPENING
0.1	3.69 X 3.69
0.125	3.3 X 3.3 (SHOWN)
0.15	3.01 X 3.01
0.175	2.79 X 2.79

4214868/A 02/2017

NOTES: (continued)

10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
11. Board assembly site may have different recommendations for stencil design.

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Last updated 10/2025